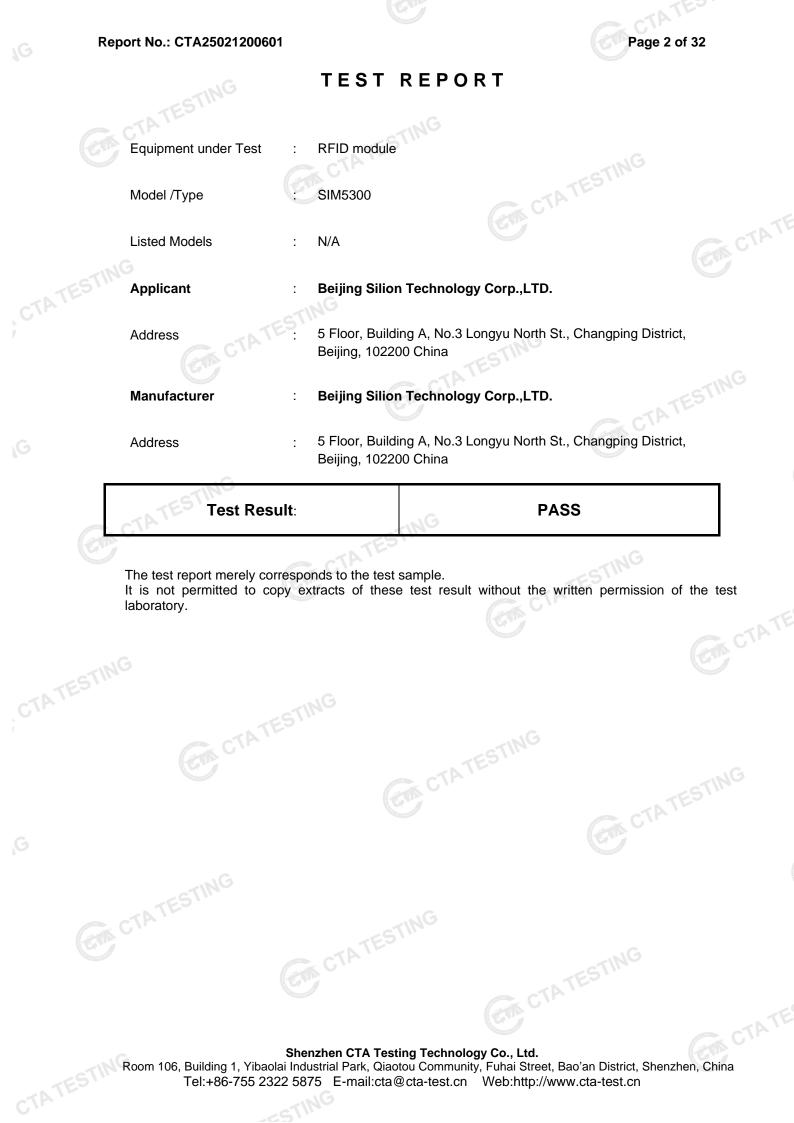
Shenzhen CTA Testing Technology Co., Ltd.



Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao'an District, Shenzhen, China

	ECC DADT 15 947	
	FCC PART 15.247	
Report Reference No	CTA25021200601	ATESTING
FCC ID :	2AQ9M-SIM530002	
Compiled by		Too. 114.
(position+printed name+signature):	File administrators Joan Wu	Jour VVV
Supervised by		Strong Page
(position+printed name+signature):	Project Engineer Zoey Cao	Ant
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Date of issue	Mar. 06, 2025	
Testing Laboratory Name	Shenzhen CTA Testing Technology	Co. Ltd
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Applicant's name	Beijing Silion Technology Corp.,LTI	D.
Address	5 Floor, Building A, No.3 Longyu North	St., Changping District,
Address:	Beijing, 102200 China	2. 2
	1.5	
Test specification:	TESTIN	. C.
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1 TEST STANDARDS

The tests were performed according to following standards:

<u>FCC Rules Part 15.247</u>: Frequency Hopping, Direct Spread Spectrum and Hybrid Systems that are in operation within the bands of 902-928 MHz, 2400-2483.5 MHz, and 5725-5850 MHz. <u>ANSI C63.10-2013</u>: American National Standard for Testing Unlicensed Wireless Devices

2 SUMMARY

2.1 General Remarks

2.1 General Remarks		
Date of receipt of test sample		Feb. 12, 2025
Testing commenced on	<u>.</u>	Feb. 12, 2025
		Feb. 12, 2025
Testing concluded on	:	Mar. 06, 2025

2.2 Product Description

Product Description:	RFID module
Model/Type reference:	SIM5300
Power supply:	DC 5.0V from external circuit
Test board	Supplied by the manufacturer
Hardware version:	SIM7300_REV2.0
Software version:	24.11.05.01
Testing sample ID:	CTA250212006-1# (Engineer sample), CTA250212006-2# (Normal sample)
RFID	
Modulation Technology:	ASK
Operation frequency:	902.75MHz-927.25MHz
Channel number:	50
Antenna type:	External antenna
Antenna gain:	6.00 dBi
Note:	Eight antennas cannot be used at the same time.

Equipment Under Test 2.3

Power supply system utilised

Power supply voltage	: (🔾 230V / 50 H	z	○ 120V / 60Hz
	(○ 12 V DC	TES	○ 24 V DC
		 Other (spec 	ified in blank belo	w)
	D	C 5.0V from ex	ternal circuit	CTATES'
2.4 Short description of	the Equ	uipment und	der Test (EUT)	(GIA)

2.4 Short description of the Equipment under Test (EUT)

This is a RFID module. For more details, refer to the user's manual of the EUT.

EUT configuration 2.5

The following peripheral devices and interface cables were connected during the measurement:

 supplied by the manufacturer supplied by the lab 	
Adapter	Input: AC 100-240V 50/60Hz Output: DC 5V 3A
O PC	Model: E470C Trade Mark: thinkpad

2.6 EUT operation mode

The Applicant provides communication tools software(Engineer mode) to control the EUT for staying in continuous transmitting (Duty Cycle more than 98%) and receiving mode for testing .There are 50 channels provided to the EUT and Channel 01/25/50 were selected to test.

Operation Frequency:

	Channel	Frequency (MHz)
	01	902.75
	02	903.25
		:
<u></u>	24	914.25
	25	914.75
k C Th	26	915.25
	TES	
P	49	926.75
	50	927.25

Block Diagram of Test Setup 2.7



DC 5V From Test board (AC 120V/60Hz)	

TATESTING

Related Submittal(s) / Grant (s) 2.8

This submittal(s) (test report) is intended for the device filing to comply with Section 15.247 of the FCC Part 15, Subpart C Rules.

2.9 Modifications

No modifications were implemented to meet testing criteria. CTATESTING

TEST ENVIRONMENT 3

3.1 Address of the test laboratory

Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao'an District, Shenzhen, China

3.2 Test Facility

The test facility is recognized, certified, or accredited by the following organizations: FCC-Registration No.: 517856 Designation Number: CN1318

Shenzhen CTA Testing Technology Co., Ltd. has been listed on the US Federal Communications Commission list of test facilities recognized to perform electromagnetic emissions measurements.

A2LA-Lab Cert. No.: 6534.01

Shenzhen CTA Testing Technology Co., Ltd. has been listed by American Association for Laboratory Accreditation to perform electromagnetic emission measurement.

The 3m-Semi anechoic test site fulfils CISPR 16-1-4 according to ANSI C63.10 and CISPR 16-1-4:2010.

3.3 Environmental conditions

During the measurement the environmental conditions were within the listed ranges:

Radiated Emission:

Temperature:	24 ° C
Gib	
Humidity:	45 %
Atmospheric pressure:	950-1050mbar

AC Power Conducted Emission:

Temperature:	25 ° C
Humidity:	46 %
-ESTI	
Atmospheric pressure:	950-1050mbar
Autospheric pressure.	950-1050mbai

950-1050mbar
25 0
44 %
950-1050mbar
CTATESTING

3.4 Summary of measurement results

	Test Specification clause	Test case	Test Mode	Test Channel		orded eport	Test result
	§15.247(a)(1)	Carrier Frequency separation	ASK	⊠ Lowest ⊠ Middle ⊠ Highest	ASK	Middle	Compliant
	§15.247(a)(1)	Number of Hopping channels	ASK	🛛 Full	ASK	🛛 Full	Compliant
G	§15.247(a)(1)	Time of Occupancy (dwell time)	ASK	 ☑ Lowest ☑ Middle ☑ Highest 	ASK	X Middle	Compliant
TE	§15.247(a)(1)	Spectrumbandwidth of aFHSS system20dB bandwidth	ASK	⊠ Lowest ⊠ Middle ⊠ Highest	ASK	⊠ Lowest ⊠ Middle ⊠ Highest	Compliant
	§15.247(b)(1)	Maximum output peak power	ASK	 ☑ Lowest ☑ Middle ☑ Highest 	ASK	⊠ Lowest ⊠ Middle ⊠ Highest	Compliant
	§15.247(d)	Band edgecompliance conducted	ASK	⊠ Lowest ⊠ Highest	ASK	⊠ Lowest ⊠ Highest	Compliant
	§15.205	Band edgecompliance radiated	ASK	⊠ Lowest ⊠ Highest	ASK	⊠ Lowest ⊠ Highest	Compliant
	§15.247(d)	TX spuriousemissions conducted	ASK	⊠ Lowest ⊠ Middle ⊠ Highest	ASK	⊠ Lowest ⊠ Middle ⊠ Highest	Compliant
	§15.247(d)	TX spuriousemissions radiated	ASK	 ☑ Lowest ☑ Middle ☑ Highest 	ASK	⊠ Lowest ⊠ Middle ⊠ Highest	Compliant
	§15.209(a)	TX spurious Emissions radiated Below 1GHz	ASK	⊠ Lowest ⊠ Middle ⊠ Highest	ASK	Middle	Compliant
	§15.107(a) §15.207	Conducted Emissions 9KHz-30 MHz	ASK	⊠ Lowest ⊠ Middle ⊠ Highest	ASK	🛛 Middle	Compliant

3.5 Statement of the measurement uncertainty

The data and results referenced in this document are true and accurate. The reader is cautioned that there may be errors within the calibration limits of the equipment and facilities. The measurement uncertainty was calculated for all measurements listed in this test report acc. to TR-100028-01" Electromagnetic compatibility and Radio spectrum Matters (ERM); Uncertainties in the measurement of mobile radio equipment characteristics; Part 1" and TR-100028-02 "Electromagnetic compatibility and Radio spectrum Matters (ERM);Uncertainties in the measurement of mobile radio equipment characteristics; Part 2 " and is documented in the Shenzhen CTA Testing Technology Co., Ltd. quality system acc. to DIN EN ISO/IEC 17025. Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device. Hereafter the best measurement capability for Shenzhen CTA Testing Technology Co., Ltd. :

Test	Range	Measurement Uncertainty	Notes
Radiated Emission	9KHz~30MHz	3.02 dB	(1)
Radiated Emission	30~1000MHz	4.06 dB	(1)
Radiated Emission	1~18GHz	5.14 dB	(1)
Radiated Emission	18-40GHz	5.38 dB	(1)
Conducted Disturbance	0.15~30MHz	2.14 dB	(1)
Output Peak power	30MHz~18GHz	0.55 dB	(1)
Power spectral density	/	0.57 dB	(1)
Spectrum bandwidth		1.1%	(1)

	Radiated spurious emission (30MHz-1GHz)	30~1000MHz	4.10 dB	(1)
-7P	Radiated spurious emission (1GHz-18GHz)	1~18GHz	4.32 dB	(1)
	Radiated spurious emission (18GHz-40GHz)	18-40GHz	5.54 dB	(1)

(1) This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

3.6 **Equipments Used during the Test**

		-				
	Test Equipment	Manufacturer	Model No.	Equipment No.	Calibration Date	Calibration Due Date
TE	LISN	R&S	ENV216	CTA-308	2024/08/03	2025/08/02
	LISN	R&S	ENV216	CTA-314	2024/08/03	2025/08/02
	EMI Test Receiver	R&S	ESPI	CTA-307	2024/08/03	2025/08/02
	EMI Test Receiver	R&S	ESCI	CTA-306	2024/08/03	2025/08/02
	Spectrum Analyzer	Agilent	N9020A	CTA-301	2024/08/03	2025/08/02
	Spectrum Analyzer	R&S	FSU	CTA-337	2024/08/03	2025/08/02
	Vector Signal generator	G	N5182A	CTA-305	2024/08/03	2025/08/02
	Analog Signal Generator	R&S	SML03	CTA-304	2024/08/03	2025/08/02
	WIDEBAND RADIO COMMUNICATION TESTER	CMW500	R&S	CTA-302	2024/08/03	2025/08/02
	Temperature and humidity meter	Chigo	ZG-7020	CTA-326	2024/08/03	2025/08/02
	Ultra-Broadband Antenna	Schwarzbeck	VULB9163	CTA-310	2023/10/17	2026/10/16
_	Horn Antenna	Schwarzbeck	BBHA 9120D	CTA-309	2023/10/13	2026/10/12
E	Loop Antenna	Zhinan	ZN30900C	CTA-311	2023/10/17	2026/10/16
	Broadband Horn Antenna	A-INFOMW	LB-180500H-2.4F	CTA-336	2023/09/13	2026/09/12
	Amplifier	Schwarzbeck	BBV 9745	CTA-312	2024/08/03	2025/08/02
	Amplifier	Taiwan chengyi	EMC051845B	CTA-313	2024/08/03	2025/08/02
	Directional coupler	NARDA	4226-10	CTA-303	2024/08/03	2025/08/02
	High-Pass Filter	XingBo	XBLBQ-GTA18	CTA-402	2024/08/03	2025/08/02
	High-Pass Filter	G XingBo	XBLBQ-GTA27	CTA-403	2024/08/03	2025/08/02
	Automated filter bank	Tonscend	JS0806-F	CTA-404	2024/08/03	2025/08/02
	Power Sensor	Agilent	U2021XA	CTA-405	2024/08/03	2025/08/02
	Amplifier	Schwarzbeck	BBV9719	CTA-406	2024/08/03	2025/08/02



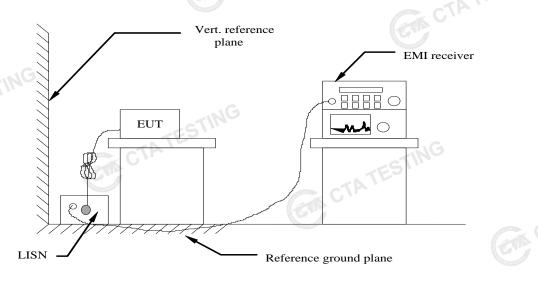
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Test Equipment	C Manufacturer	Model No.	Version number	Calibration Date	Calibration Due Date	
EMI Test Software	Tonscend	TS®JS32-RE	5.0.0.2	N/A	N/A	
EMI Test Software	Tonscend	TS®JS32-CE	5.0.0.1	N/A	N/A	
RF Test Software	Tonscend	TS®JS1120-3	3.1.65	N/A	N/A	
RF Test Software	Tonscend	TS®JS1120	3.1.46	N/A	N/A	TE
STING					CAN C	j.

4 TEST CONDITIONS AND RESULTS

4.1 AC Power Conducted Emission

TEST CONFIGURATION



TEST PROCEDURE

1 The equipment was set up as per the test configuration to simulate typical actual usage per the user's manual. The EUT is a tabletop system, a wooden table with a height of 0.8 meters is used and is placed on the ground plane as per ANSI C63.10-2013.

2 Support equipment, if needed, was placed as per ANSI C63.10-2013

3 All I/O cables were positioned to simulate typical actual usage as per ANSI C63.10-2013

4 The EUT received power from adapter, the adapter received AC120V/60Hz and AC 240V/60Hz power through a Line Impedance Stabilization Network (LISN) which supplied power source and was grounded to the ground plane.

5 All support equipments received AC power from a second LISN, if any.

6 The EUT test program was started. Emissions were measured on each current carrying line of the EUT using a spectrum Analyzer / Receiver connected to the LISN powering the EUT.The LISN has two monitoring points: Line 1 (Hot Side) and Line 2 (Neutral Side). Two scans were taken: one with Line 1 connected to Analyzer / Receiver and Line 2 connected to a 50 ohm load; the second scan had Line 1 connected to a 50 ohm load and Line 2 connected to the Analyzer / Receiver.

7 Analyzer / Receiver scanned from 150 KHz to 30MHz for emissions in each of the test modes.

8 During the above scans, the emissions were maximized by cable manipulation.

AC Power Conducted Emission Limit

For intentional device, according to § 15.207(a) AC Power Conducted Emission Limits is as following :

	Limit (dBuV)			
Frequency range (MHz)	Quasi-peak	Average		
0.15-0.5	66 to 56*	56 to 46*		
0.5-5	56	46		
5-30	60	50		
		00		

* Decreases with the logarithm of the frequency.

TEST RESULTS

Remark:

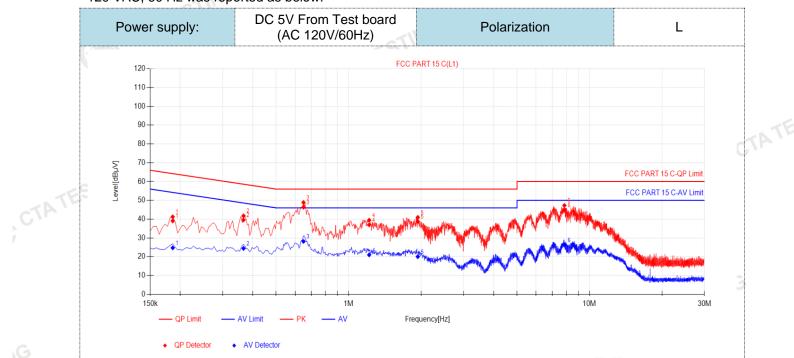
1. RFID were test at Low, Middle, and High channel; only the worst result of RFID Middle Channel was reported as below:

Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao'an District, Shenzhen, China Tel:+86-755 2322 5875 E-mail:cta@cta-test.cn Web:http://www.cta-test.cn

ESTING

2. Both 120 VAC, 50/60 Hz and 240 VAC, 50/60 Hz power supply have been tested, only the worst result of 120 VAC, 60 Hz was reported as below:

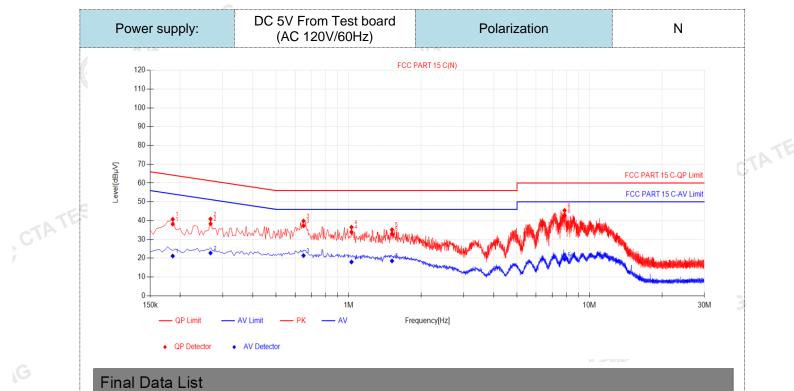


Final Data List

NO.	Freq. [MHz]	Factor [dB]	QP Reading[dB µV]	QP Value [dBµV]	QP Limit [dBµV]	QP Margin [dB]	A∨ Reading [dBµ∨]	AV Value [dBµV]	AV Limit [dBµV]	A∨ Margin [dB]	Verdict
1	0.186	10.03	29.03	39.06	64.21	25.15	14.70	24.73	54.21	29.48	PASS
2	0.366	9.87	29.71	39.58	58.59	19.01	14.57	24.44	48.59	24.15	PASS
3	0.6495	9.98	36.38	46.36	56.00	9.64	18.17	28.15	46.00	17.85	PASS
4	1.2165	9.90	27.06	36.96	56.00	19.04	11.10	21.00	46.00	25.00	PASS
5	1.9365	9.92	28.93	38.85	56.00	17.15	10.13	20.05	46.00	25.95	PASS
6	7.8675	10.28	34.70	44.98	60.00	15.02	16.02	26.30	50.00	23.70	PASS
).QP Value tor (dB)=ir					-	-				
3), QPI	Margin(dB) = OPL	imit (dBu	V) - QP '	Value (dl	BuV)					

- 2). Factor (dB)=insertion loss of LISN (dB) + Cable loss (dB)
- 3). QPMargin(dB) = QP Limit (dB μ V) QP Value (dB μ V)
- 4). AVMargin(dB) = AV Limit (dB μ V) AV Value (dB μ V)

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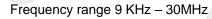
F	inai	Data	LIST	

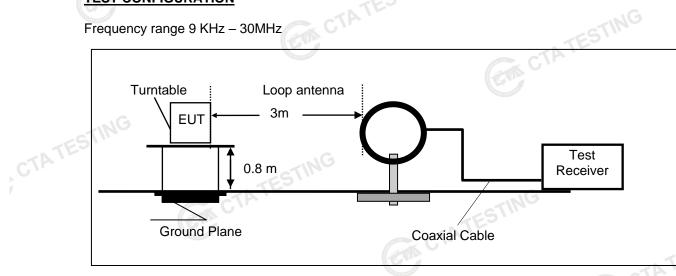
NO.	Freq. [MHz]	Factor [dB]	QP Reading[dB µV]	QP Value [dBµV]	QP Limit [dBµV]	QP Margin [dB]	AV Reading [dBµV]	A∨ Value [dBµV]	A∨ Limit [dBµV]	AV Margin [dB]	Verdict	
1	0.186	10.01	28.17	38.18	64.21	26.03	11.16	21.17	54.21	33.04	PASS	
2	0.267	9.97	28.36	38.33	61.21	22.88	12.81	22.78	51.21	28.43	PASS	
3	0.6495	10.11	27.13	37.24	56.00	18.76	11.31	21.42	46.00	24.58	PASS	
4	1.0275	10.13	23.81	33.94	56.00	22.06	7.89	18.02	46.00	27.98	PASS	
5	1.5135	10.13	22.87	33.00	56.00	23.00	8.42	18.55	46.00	27.45	PASS	
6	7.881	10.42	32.25	42.67	60.00	17.33	9.03	19.45	50.00	30.55	PASS	
Note:1).QP Value $(dB\mu V)$ = QP Reading $(dB\mu V)$ + Factor (dB) 2). Factor (dB) =insertion loss of LISN (dB) + Cable loss (dB) 3). QPMargin (dB) = QP Limit $(dB\mu V)$ - QP Value $(dB\mu V)$ 4). AVMargin (dB) = AV Limit $(dB\mu V)$ - AV Value $(dB\mu V)$										TAT		
	1 2 3 4 5 6 0 0 te:1) . Fact	NO. [MHz] 1 0.186 2 0.267 3 0.6495 4 1.0275 5 1.5135 6 7.881 Dte:1).QP Value . Factor (dB)=in . QPMargin(dB)	NO [MHz] [dB] 1 0.186 10.01 2 0.267 9.97 3 0.6495 10.11 4 1.0275 10.13 5 1.5135 10.13 6 7.881 10.42 Dte:1).QP Value (dBµV)= Factor (dB)=insertion log . QPMargin(dB) = QP Li	NO. Freq. [MHz] Factor [dB] Reading[dB] $\mu V]$ 1 0.186 10.01 28.17 2 0.267 9.97 28.36 3 0.6495 10.11 27.13 4 1.0275 10.13 23.81 5 1.5135 10.13 22.87 6 7.881 10.42 32.25 ote:1).QP Value (dB μ V)= QP Real Factor (dB)=insertion loss of LIS QPMargin(dB) = QP Limit (dB μ V)	NO. Freq. [MHz] Factor [dB] Reading[dB] μ V] Value [dBµV] 1 0.186 10.01 28.17 38.18 2 0.267 9.97 28.36 38.33 3 0.6495 10.11 27.13 37.24 4 1.0275 10.13 23.81 33.94 5 1.5135 10.13 22.87 33.00 6 7.881 10.42 32.25 42.67 ote:1).QP Value (dBµV)= QP Reading (dB) Factor (dB)=insertion loss of LISN (dB) - QPMargin(dB) = QP Limit (dBµV) - QP V	NO. Freq. [MHz] Factor [dB] Reading[dB] $\nu V]$ Value [dB $\mu V]$ Limit [dB $\mu V]$ 1 0.186 10.01 28.17 38.18 64.21 2 0.267 9.97 28.36 38.33 61.21 3 0.6495 10.11 27.13 37.24 56.00 4 1.0275 10.13 23.81 33.94 56.00 5 1.5135 10.13 22.87 33.00 56.00 6 7.881 10.42 32.25 42.67 60.00 ptet:1).QP Value (dB μ V)= QP Reading (dB μ V)+ Fa Factor (dB)=insertion loss of LISN (dB) + Cable I Factor (dB)=insertion loss of LISN (dB) + Cable I Factor (dB)=insertion loss of LISN (dB) + Cable I	NO. Freq. [MHz] Factor [dB] Reading[dB] μ V] Value [dBµV] Limit [dBµV] Margin [dB] 1 0.186 10.01 28.17 38.18 64.21 26.03 2 0.267 9.97 28.36 38.33 61.21 22.88 3 0.6495 10.11 27.13 37.24 56.00 18.76 4 1.0275 10.13 23.81 33.94 56.00 22.06 5 1.5135 10.13 22.87 33.00 56.00 23.00 6 7.881 10.42 32.25 42.67 60.00 17.33 otte:1).QP Value (dBµV)= QP Reading (dBµV)+ Factor (dB Factor (dB)=insertion loss of LISN (dB) + Cable loss (dB) . . QPMargin(dB) = QP Limit (dBµV) - QP Value (dBµV) - QP Value (dBµV) .	NO.Freq. [MHz]Factor [dB]Reading[dB μ V]Value [dB μ V]Limit [dB μ V]Margin [dB]Reading [dB μ V]10.18610.0128.1738.1864.2126.0311.1620.2679.9728.3638.3361.2122.8812.8130.649510.1127.1337.2456.0018.7611.3141.027510.1323.8133.9456.0022.067.8951.513510.1322.8733.0056.0023.008.4267.88110.4232.2542.6760.0017.339.03ote:1).QP Value (dBµV)= QP Reading (dBµV)+ Factor (dB). Factor (dB)=insertion loss of LISN (dB) + Cable loss (dB). QPMargin(dB) = QP Limit (dBµV) - QP Value (dBµV)	NO.Freq. [MHz]Factor [dB]Reading[dB µV]Value [dBµV]Limit [dBµV]Margin [dBµV]Reading [dBµV]Value [dBµV]10.18610.0128.1738.1864.2126.0311.1621.1720.2679.9728.3638.3361.2122.8812.8122.7830.649510.1127.1337.2456.0018.7611.3121.4241.027510.1323.8133.9456.0022.067.8918.0251.513510.1322.8733.0056.0023.008.4218.5567.88110.4232.2542.6760.0017.339.0319.45otte:1).QP Value (dBµV)= QP Reading (dBµV)+ Factor (dB). Factor (dB)=insertion loss of LISN (dB) + Cable loss (dB). QPMargin(dB) = QP Limit (dBµV) - QP Value (dBµV)	NO. Freq. [MHz] Factor [dB] Reading[dB} μ V] Value [dB μ V] Limit [dB μ V] Margin [dB] Reading [dB μ V] Value [dB μ V] Limit [dB μ V] 1 0.186 10.01 28.17 38.18 64.21 26.03 11.16 21.17 54.21 2 0.267 9.97 28.36 38.33 61.21 22.88 12.81 22.78 51.21 3 0.6495 10.11 27.13 37.24 56.00 18.76 11.31 21.42 46.00 4 1.0275 10.13 23.81 33.94 56.00 23.00 8.42 18.55 46.00 5 1.5135 10.13 22.87 33.00 56.00 23.00 8.42 18.55 46.00 6 7.881 10.42 32.25 42.67 60.00 17.33 9.03 19.45 50.00 ote:1).QP Value (dB μ V)= QP Reading (dB μ V)+ Factor (dB) 	NO.Freq. [MHz]Factor [dB]Reading[dB] μ/J Value [dB $\mu/Y]$ Limit [dB $\mu/Y]$ Margin [dB]Reading [dB $\mu/Y]$ Value [dB $\mu/Y]$ Limit [dB $\mu/Y]$ Margin [dB $\mu/Y]$ 10.18610.0128.1738.1864.2126.0311.1621.1754.2133.0420.2679.9728.3638.3361.2122.8812.8122.7851.2128.4330.649510.1127.1337.2456.0018.7611.3121.4246.0024.5841.027510.1323.8133.9456.0022.067.8918.0246.0027.9851.513510.1322.8733.0056.0023.008.4218.5546.0027.4567.88110.4232.2542.6760.0017.339.0319.4550.0030.55ote:1).QP Value (dBµV)= QP Reading (dBµV)+ Factor (dB). Factor (dB)=insertion loss of LISN (dB) + Cable loss (dB). QPMargin(dB) = QP Limit (dBµV) - QP Value (dBµV)	NO.Freq. [MHz]Factor [dB]Reading(dB) μ/J Value [dB $\mu/Y]$ Limit [dB $\mu/Y]$ Margin [dB]Reading [dB $\mu/Y]$ Value [dB $\mu/Y]$ Limit [dB $\mu/Y]$ Margin [dB $\mu/Y]$ Wargin [dB $\mu/Y]$ Verdict10.18610.0128.1738.1864.2126.0311.1621.1754.2133.04PASS20.2679.9728.3638.3361.2122.8812.8122.7851.2128.43PASS30.649510.1127.1337.2456.0018.7611.3121.4246.0024.58PASS41.027510.1323.8133.9456.0022.067.8918.0246.0027.98PASS51.513510.1322.8733.0056.0023.008.4218.5546.0027.45PASS67.88110.4232.2542.6760.0017.339.0319.4550.0030.55PASSote:1).QP Value (dB μ V)= QP Reading (dB μ V)+ Factor (dB). Factor (dB)=insertion loss of LISN (dB) + Cable loss (dB). QPMargin(dB) = QP Limit (dB μ V) - QP Value (dB μ V)

- 3). QPMargin(dB) = QP Limit (dB μ V) QP Value (dB μ V)
- 4). AVMargin(dB) = AV Limit (dB μ V) AV Value (dB μ V) CTA TESTING

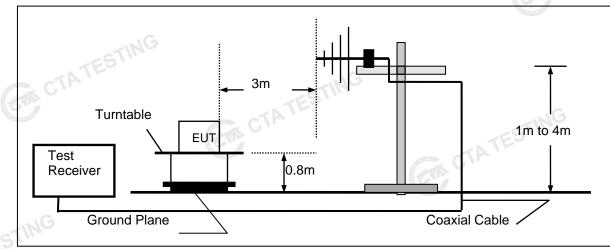
Radiated Emission 4.2

TEST CONFIGURATION

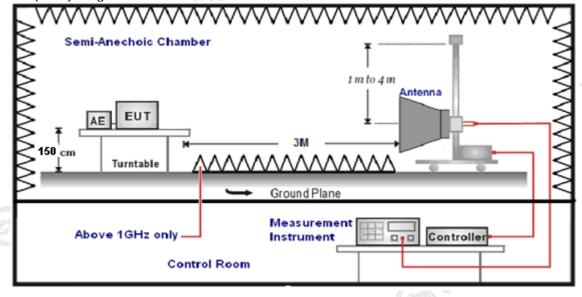




Frequency range 30MHz - 1000MHz



Frequency range above 1GHz-25GHz



TEST PROCEDURE

- 1. The EUT was placed on a turn table which is 0.8m above ground plane when testing frequency range 9 KHz -1GHz; the EUT was placed on a turn table which is 1.5m above ground plane when testing frequency range 1GHz - 25GHz.
- 2. Maximum procedure was performed by raising the receiving antenna from 1m to 4m and rotating the turn table from 0° to 360° to acquire the highest emissions from EUT.
- 3. And also, each emission was to be maximized by changing the polarization of receiving antenna both horizontal and vertical.
- Repeat above procedures until all frequency measurements have been completed. 4.
- 5. Radiated emission test frequency band from 9KHz to 25GHz. 6.

•	The distance between test antenna and EUT as following table states:					
	Test Frequency range	Test Antenna Type	Test Distance			
	9KHz-30MHz	Active Loop Antenna	3			
	30MHz-1GHz	Ultra-Broadband Antenna	3			
	1GHz-18GHz	Double Ridged Horn Antenna	3			
	18GHz-25GHz	Horn Anternna	1			

Setting test receiver/spectrum as following table states: 7.

Setting test receiver/spectrum as following table states.						
Test Frequency range	Test Receiver/Spectrum Setting	Detector				
9KHz-150KHz	RBW=200Hz/VBW=3KHz,Sweep time=Auto	QP				
150KHz-30MHz	RBW=9KHz/VBW=100KHz,Sweep time=Auto	QP				
30MHz-1GHz	RBW=120KHz/VBW=1000KHz,Sweep time=Auto	QP				
	Peak Value: RBW=1MHz/VBW=3MHz,					
1GHz-40GHz	Sweep time=Auto	Peak				
IGHZ-40GHZ	Average Value: RBW=1MHz/VBW=10Hz,	reak				
	Sweep time=Auto					

Field Strength Calculation

The field strength is calculated by adding the Antenna Factor and Cable Factor and subtracting the Amplifier Gain and Duty Cycle Correction Factor(if any) from the measured reading. The basic equation with a sample calculation is as follows:

FS = RA + AF + CL - AG

sample calculation is as follows:	ESTINC
FS = RA + AF + CL - AG	CTATEC
Where FS = Field Strength	CL = Cable Attenuation Factor (Cable Loss)
RA = Reading Amplitude	AG = Amplifier Gain
AF = Antenna Factor	

Transd=AF +CL-AG

RADIATION LIMIT

For intentional device, according to § 15.209(a), the general requirement of field strength of radiated emission from intentional radiators at a distance of 3 meters shall not exceed the following table. According to § 15.247(d), in any 100kHz bandwidth outside the frequency band in which the EUT is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20dB below that in the100kHz bandwidth within the band that contains the highest level of desired power.

The pre-test have done for the EUT in three axes and found the worst emission at position shown in test setup photos.

Frequency (MHz)	Distance (Meters)	Radiated (dBµV/m)	Radiated (µV/m)
0.009-0.49	3	20log(2400/F(KHz))+40log(300/3)	2400/F(KHz)
0.49-1.705	3	20log(24000/F(KHz))+ 40log(30/3)	24000/F(KHz)
1.705-30	3	20log(30)+ 40log(30/3)	30
30-88	3	40.0	100
88-216	3	43.5	150
216-960	3	46.0	200
Above 960	3	54.0	500

Shenzhen CTA Testing Technology Co., Ltd.

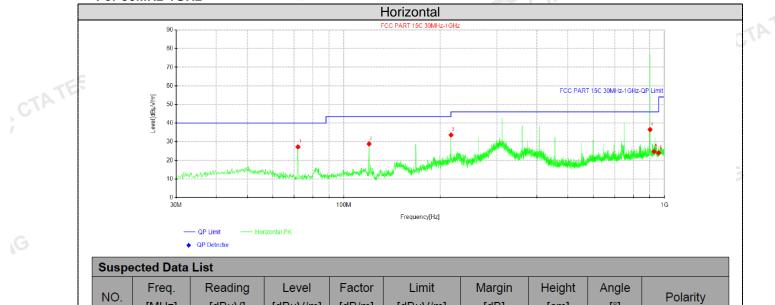
Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao'an District, Shenzhen, China Tel:+86-755 2322 5875 E-mail:cta@cta-test.cn Web:http://www.cta-test.cn

TEST RESULTS

Remark:

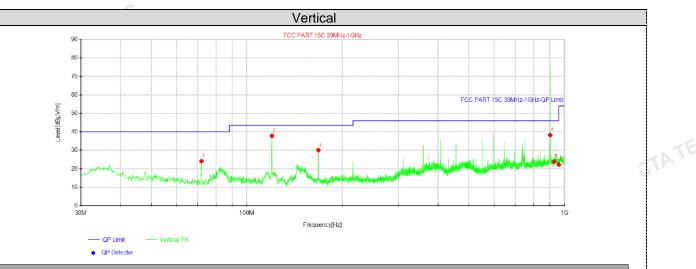
- This test was performed with EUT in X, Y, Z position and the worse case was found when EUT in X 1. position.
- 2. For below 1GHz testing recorded worst at low channel.
- 3. Radiated emission test from 9 KHz to 10th harmonic of fundamental was verified, and no emission found except system noise floor in 9 KHz to 30MHz and not recorded in this report.

For 30MHz-1GHz



	NO.	[MHz]	[dBµV]	[dBµV/m]	[dB/m]	[dBµV/m]	[dB]	[cm]	[°]	Polarity	
1	1	71.9525	42.44	27.21	-15.23	40.00	12.79	100	350	Horizontal	
	2	119.967	42.66	28.80	-13.86	43.50	14.70	100	148	Horizontal	
	3	215.997	46.21	33.63	-12.58	43.50	9.87	200	238	Horizontal	
	4	902	39.11	36.53	-2.58	46.00	9.47	100	104	Horizontal	
5 928 27.10 24.79 -2.31 46.00 21.21 100 125 Horizo											
	6	960	26.14	24.01	-2.13	54.00	29.99	200	15	Horizontal	TE
N	Note:1).Level (dBµV/m)= Reading (dBµV)+ Factor (dB/m)										
	2). Factor(dB/m)=Antenna Factor (dB/m) + Cable loss (dB) - Pre Amplifier gain (dB)										
	3) Marain(dB) – Limit (dBu)//m) – Loval (dBu)//m)										

3). Margin(dB) = Limit (dB μ V/m) - Level (dB μ V/m) CTATESTIN



Suspected Data List

CTATE

NO.	Freq.	Reading	Level	Factor	Limit	Margin	Height	Angle	Polority
NO.	[MHz]	[dBµV]	[dBµV/m]	[dB/m]	[dBµV/m]	[dB]	[cm]	[°]	Polarity
1	71.9525	39.34	24.11	-15.23	40.00	15.89	100	56	Vertical
2	119.967	51.67	37.81	-13.86	43.50	5.69	100	255	Vertical
3	167.982	45.27	30.10	-15.17	43.50	13.40	200	246	Vertical
4	902	40.82	38.24	-2.58	46.00	8.26	100	359	Vertical
5	928	26.13	23.82	-2.31	46.00	22.18	200	291	Vertical
6	960	24.40	22.27	-2.13	54.00	31.73	100	2	Vertical

CTATE

Note:1).Level (dBµV/m)= Reading (dBµV)+ Factor (dB/m)

2). Factor(dB/m)=Antenna Factor (dB/m) + Cable loss (dB) - Pre Amplifier gain (dB)

3). Margin(dB) = Limit (dB μ V/m) - Level (dB μ V/m)

For 1GHz to 10GHz

For 1GHz	to 10GHz								
Freque	ency(MHz)):	902	2.75	Pola	arity:	н	ORIZONTA	۱L
Frequency (MHz)	Le	sion vel V/m)	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
1805.5	59.86	PK	74.00	14.14	72.13	25.46	3.6	41.33	-12.27
1805.5	42.78	AV	54.00	11.22	55.05	25.46	3.6	41.33	-12.27
2708.25	49.94	PK	74.00	24.06	59.10	28.32	5.12	42.6	-9.16
2708.25	40.41	AV	54.00	13.59	49.57	28.32	5.12	42.6	-9.16
. G									5

									G
Freque	ncy(MHz)	:	902.75		Polarity:		VERTICAL		
Frequency (MHz)	Emis Lev (dBu	vel	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
1805.5	58.06	PK	74.00	15.94	70.33	25.46	3.6	41.33	-12.27
1805.5	40.79	AV	54.00	13.21	53.06	25.46	3.6	41.33	-12.27
2708.25	48.67	PK	74.00	25.33	57.83	28.32	5.12	42.6	-9.16
2708.25	38.43	AV	54.00	15.57	47.59	28.32	5.12	42.6	-9.16

Freque	Frequency(MHz):		914.75		Polarity:		HORIZONTAL		
Frequency (MHz)	Emis Lev (dBu)	/el	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
1829.5	59.19	PK	74.00	14.81	71.47	25.45	3.6	41.33	-12.28
1829.5	41.52	AV	54.00	12.48	53.80	25.45	3.6	41.33	-12.28
2744.25	50.66	PK	74.00	23.34	59.83	28.3	5.12	42.59	-9.17
2744.25	39.60	AV	54.00	14.40	48.77	28.3	5.12	6 42.59	-9.17
			Carlo U				STIN		

Freque	ncy(MHz)	:	914.75		Polarity:		VERTICAL		
Frequency (MHz)	Emis Lev (dBu)	vel	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
1829.5	57.65	PK	74.00	16.35	69.93	25.45	3.6	41.33	-12.28
1829.5	39.77	AV	54.00	14.23	52.05	25.45	3.6	41.33	-12.28
2744.25	48.75	PK	74.00	25.25	57.92	28.3	5.12	42.59	-9.17
2744.25	38.86	AV	54.00	15.14	48.03	28.3	5.12	42.59	-9.17

Freque	ncy(MHz)	:	927.25		Polarity:		HORIZONTAL		
Frequency (MHz)	-	sion vel V/m)	Limit (dBuV/m)	Margin (dB)	Raw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
1854.5	58.64	PK	74.00	15.36	70.79	25.62	3.63	41.4	-12.15
1854.5	41.21	AV	54.00	12.79	53.36	25.62	3.63	41.4	-12.15
2781.75	50.83	PK	74.00	23.17	59.93	28.46	5.14	42.7	-9.1
2781.75	39.79	AV	54.00	14.21	48.89	28.46	5.14	42.7	-9.1
	-11	1G							

Frequency(MHz):			927.25		Polarity:		VERTICAL		
Frequency (MHz)	Emis Lev (dBu)	vel	Limit (dBuV/m)	Margin (dB)	CRaw Value (dBuV)	Antenna Factor (dB/m)	Cable Factor (dB)	Pre- amplifier (dB)	Correction Factor (dB/m)
1854.5	57.03	PK	74.00	16.97	69.18	25.62	3.63	41.4	-12.15
1854.5	40.14	AV	54.00	13.86	52.29	25.62	3.63	41.4	-12.15
2781.75	49.08	PK	74.00	24.92	58.18	28.46	5.14	42.7	-9.1
2781.75	38.13	AV	54.00	15.87	47.23	28.46	5.14	42.7	-9.1

REMARKS:

- 1. Emission level (dBuV/m) =Raw Value (dBuV)+Correction Factor (dB/m)
- 2. Correction Factor (dB/m) = Antenna Factor (dB/m)+Cable Factor (dB)- Pre-amplifier
- 3. Margin value = Limit value- Emission level.
- 4. -- Mean the PK detector measured value is below average limit.
- 5. The other emission levels were very low against the limit.

4.3 Maximum Peak Output Power

Limit

The Maximum Peak Output Power Measurement is 1W (30dBm).

Test Procedure

Remove the antenna from the EUT and then connect a low loss RF cable from the antenna port to the powersensor.

<u>Test Configuration</u>

Test Configuration



Test Results

Channel	Output power (dBm)	Limit (dBm)	Result
CH01	29.449		TATES
CH25	29.749	30.0	Pass
CH50	29.312		

Note: 1.The test results including the cable loss.

20dB Bandwidth 4.4

Limit

For frequency hopping systems operating in the 902MHz-928MHz no limit for 20dB bandwidth.

Test Procedure

The transmitter output was connected to the spectrum analyzer through an attenuator. The bandwidth of the fundamental frequency was measured by spectrum analyzer with 30 KHz RBW and 100 KHz VBW.

The 20dB bandwidth is defined as the total spectrum the power of which is higher than peak power minus 20dB.

Test Configuration



Test Results

Test Results	ANALYZER	CTATESTING
Channel	20dB bandwidth (MHz)	Result
CH01	0.2112	
CH25	0.2106	Pass
CH50	0.2139	
Test plot as follows:	CTATES C	TATESTING





4.5 Frequency Separation

LIMIT

According to 15.247(a)(1), frequency hopping systems shall have hopping channel carrier frequencies separated by minimum of 25KHz or the 20dB bandwidth of the hopping channel, whichever is greater.

TEST PROCEDURE

The transmitter output was connected to the spectrum analyzer through an attenuator. The bandwidth of the CTATE fundamental frequency was measured by spectrum analyzer with 30 KHz RBW and 100 KHz VBW.

TEST CONFIGURATION



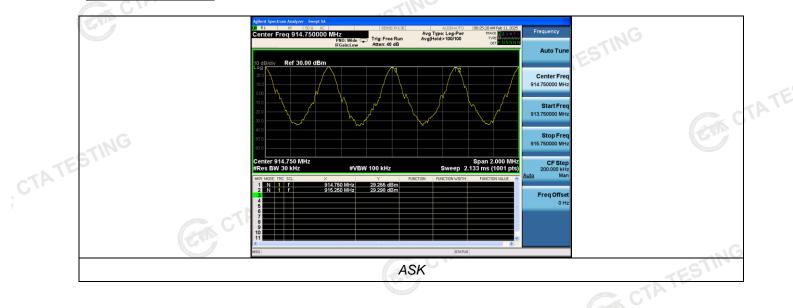
TEST RESULTS

and the second se			
Channel	Channel Separation (MHz)	Limit(MHz)	Result
CH24	0.5		CTA Daga
CH25	0.5	25KHz	Pass

Note:

We have tested all mode at high, middle and low channel, and recorded worst case at middle

Test plot as follows:



Number of hopping frequency 4.6

Limit C

≥50 For Frequency hopping systems in the 902–928MHz band

Test Procedure

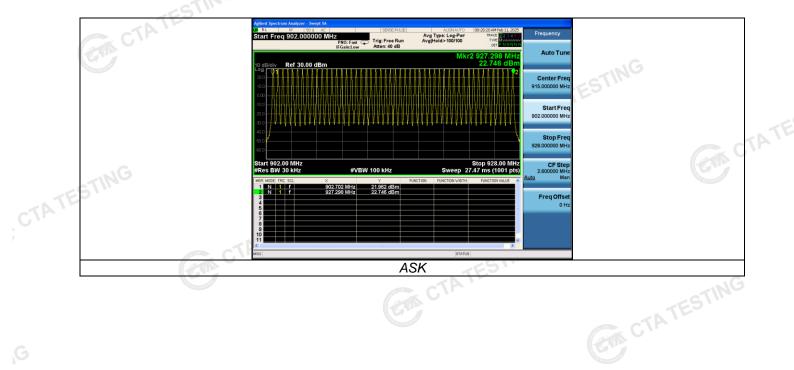
TATESTING GTA CTATE The transmitter output was connected to the spectrum analyzer through an attenuator. Set spectrum analyzer start 903MHz to 906MHz with 100 KHz RBW and 300 KHz VBW.

Test Configuration CTATES



Test Results	CTATES CTATES	STING
Number of Hopping Channel	Limit	Result
50	≥50	Pass

Test plot as follows:



4.7 Time of Occupancy (Dwell Time)

Limit CTP

For frequency hopping systems operating in the 902-928 MHz band: if the 20 dB bandwidth of the hopping channel is less than 250 kHz, the system shall use at least 50 hopping frequencies and the average time of occupancy on any frequency shall not be greater than 0.4 seconds within a 20 second period;

Test Procedure

The transmitter output was connected to the spectrum analyzer through an attenuator. Set center frequency of spectrum analyzer=operating frequency with 1MHz RBW and 1MHz VBW, Span 0Hz.

Test Configuration

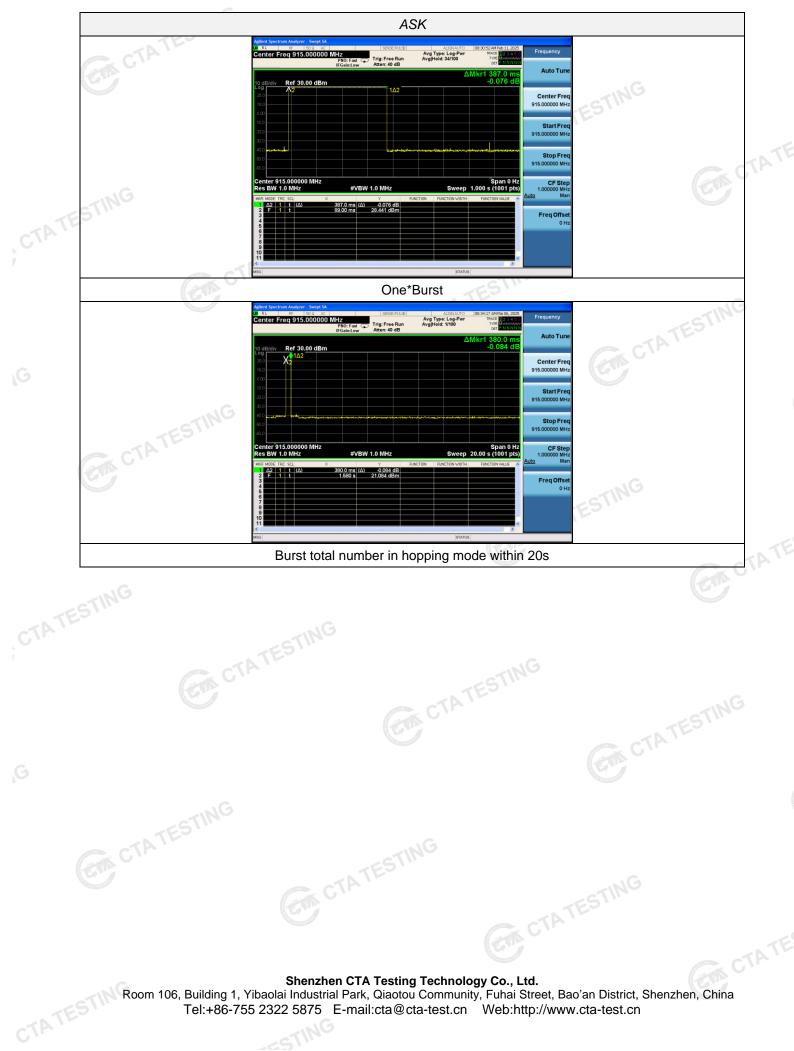


Test Results

Test Results		ANALYZER		<u>{</u>	CTATESTING	
СН	Burst time (s)	Dwell time (s)	Limit (s)	Result		
25	0.387	0.380	0.40	Pass		

Note: We have tested all mode at high, middle and low channel, and recoreded worst case at middle channel. Test plot as follows:

Report No.: CTA25021200601



ESTING

4.8 **Out-of-band Emissions**

Limit C

In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, pro-vided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter com-plies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in §15.209(a) is not required.

Test Procedure

Connect the transmitter output to spectrum analyzer using a low loss RF cable, and set the spectrum analyzer to RBW=100 kHz, VBW= 300 kHz, peak detector, and max hold. Measurements utilizing these setting are GTA CTATESTING made of the in-band reference level, bandedge and out-of-band emissions.

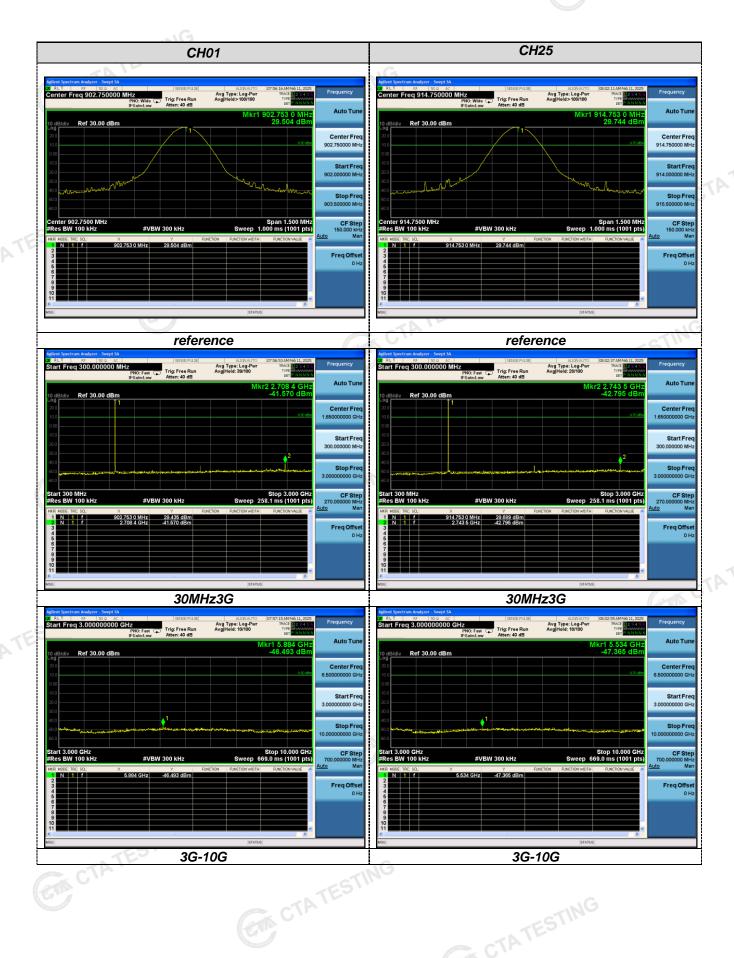
Test Configuration



Test Results

Remark: The measurement frequency range is from 30MHz to the 10th harmonic of the fundamental frequency. The lowest, middle and highest channels are tested to verify the spurious emissions and bandage measurement data.

Test plot as follows:







Band-edge Measurements for RF Conducted Emissions:

4.9 Antenna Requirement

Standard Applicable

For intentional device, according to FCC 47 CFR Section 15.203, an intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device.

And according to FCC 47 CFR Section 15.247 (c), if transmitting antennas of directional gain greater than 6dBi are used, the power shall be reduced by the amount in dB that the directional gain of the antenna exceeds 6dBi.

Refer to statement below for compliance

The manufacturer may design the unit so that the user can replace a broken antenna, but the use of a standard antenna jack or electrical connector is prohibited. Further, this requirement does not apply to intentional radiators that must be professionally installed.

Antenna Connected Construction

The maximum gain of antenna was 6.00 dBi.

Remark: The antenna gain is provided by the customer , if the data provided by the customer is not accurate, Shenzhen CTA Testing Technology Co., Ltd. does not assume any responsibility.

5 Test Setup Photos of the EUT

Please refer to separated files for Test Setup Photos of the EUT.

Please refer to separated files for External & Internal Photos of the EUT.